



PSMN4R6-100XS

N-channel 100V 4.6 mΩ standard level MOSFET in TO220F (SOT186A)

Rev. 1 — 3 July 2012

Product data sheet

1. Product profile

1.1 General description

Standard level N-channel MOSFET in TO220F (SOT186A) package qualified to 175C. This product is designed and qualified for use in a wide range of industrial, communications and domestic equipment.

1.2 Features and benefits

- High efficiency due to low switching and conduction losses
- Isolated package
- Suitable for standard level gate drive

1.3 Applications

- AC-to-DC power supply equipment
- Server power supplies
- Motor control
- Synchronous rectification

1.4 Quick reference data

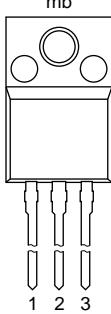
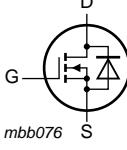
Table 1. Quick reference data

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25^\circ\text{C}; T_j \leq 175^\circ\text{C}$	-	-	100	V
I_D	drain current	$T_{mb} = 25^\circ\text{C}; V_{GS} = 10\text{ V}$; see Figure 1	-	-	70.4	A
P_{tot}	total power dissipation	$T_{mb} = 25^\circ\text{C}$; see Figure 2	-	-	63.8	W
Static characteristics						
R_{DSon}	drain-source on-state resistance	$V_{GS} = 10\text{ V}; I_D = 15\text{ A}; T_j = 25^\circ\text{C}$; see Figure 12 ; see Figure 13	-	3.95	4.6	mΩ
Dynamic characteristics						
Q_{GD}	gate-drain charge	$V_{GS} = 10\text{ V}; I_D = 15\text{ A}; V_{DS} = 50\text{ V}$	-	40	-	nC
$Q_{G(tot)}$	total gate charge	see Figure 14 ; see Figure 15	-	153	-	nC
Avalanche ruggedness						
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	$V_{GS} = 10\text{ V}; T_{j(init)} = 25^\circ\text{C}$; $I_D = 70.4\text{ A}$; $V_{sup} \leq 100\text{ V}$; unclamped; $R_{GS} = 50\Omega$; see Figure 3	-	-	673	mJ



2. Pinning information

Table 2. Pinning information

Pin	Symbol	Description	Simplified outline	Graphic symbol
1	G	gate		
2	D	drain		
3	S	source		
mb		mounting base; isolated		

SOT186A

3. Ordering information

Table 3. Ordering information

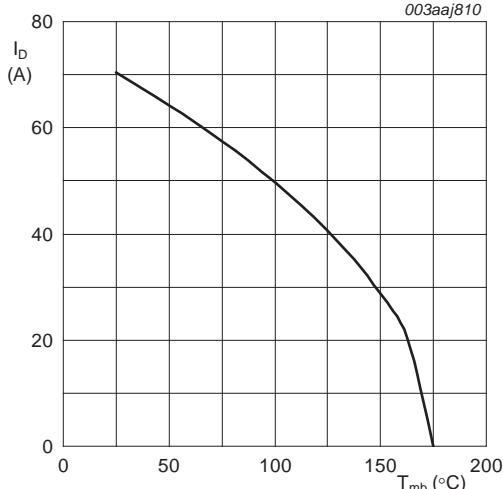
Type number	Package		Version
	Name	Description	
PSMN4R6-100XS	-	plastic single-ended package; isolated heatsink mounted; 1 mounting hole; 3-lead TO-220 "full pack"	SOT186A

4. Limiting values

Table 4. Limiting values

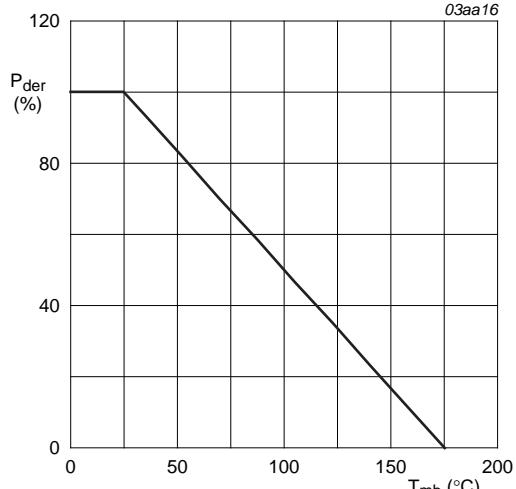
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Min	Max	Unit
V_{DS}	drain-source voltage	$T_j \geq 25^\circ\text{C}; T_j \leq 175^\circ\text{C}$	-	100	V
V_{DGR}	drain-gate voltage	$T_j \geq 25^\circ\text{C}; T_j \leq 175^\circ\text{C}; R_{GS} = 20\text{ k}\Omega$	-	100	V
V_{GS}	gate-source voltage		-20	20	V
I_D	drain current	$V_{GS} = 10\text{ V}; T_{mb} = 25^\circ\text{C}$; see Figure 1	-	70.4	A
		$V_{GS} = 10\text{ V}; T_{mb} = 100^\circ\text{C}$; see Figure 1	-	49.7	A
I_{DM}	peak drain current	pulsed; $t_p \leq 10\text{ }\mu\text{s}; T_{mb} = 25^\circ\text{C}$; see Figure 4	-	281	A
P_{tot}	total power dissipation	$T_{mb} = 25^\circ\text{C}$; see Figure 2	-	63.8	W
T_{stg}	storage temperature		-55	175	°C
T_j	junction temperature		-55	175	°C
$T_{sld(M)}$	peak soldering temperature		-	260	°C
Source-drain diode					
I_S	source current	$T_{mb} = 25^\circ\text{C}$	-	53.2	A
I_{SM}	peak source current	pulsed; $t_p \leq 10\text{ }\mu\text{s}; T_{mb} = 25^\circ\text{C}$	-	281	A
Avalanche ruggedness					
$E_{DS(AL)S}$	non-repetitive drain-source avalanche energy	$V_{GS} = 10\text{ V}; T_{j(\text{init})} = 25^\circ\text{C}; I_D = 70.4\text{ A}; V_{sup} \leq 100\text{ V}$; unclamped; $R_{GS} = 50\text{ }\Omega$; see Figure 3	-	673	mJ



$V_{GS} \geq 10\text{ V}$

Fig 1. Continuous drain current as a function of mounting base temperature



$$P_{der} = \frac{P_{tot}}{P_{tot}(25^\circ\text{C})} \times 100\%$$

Fig 2. Normalized total power dissipation as a function of mounting base temperature

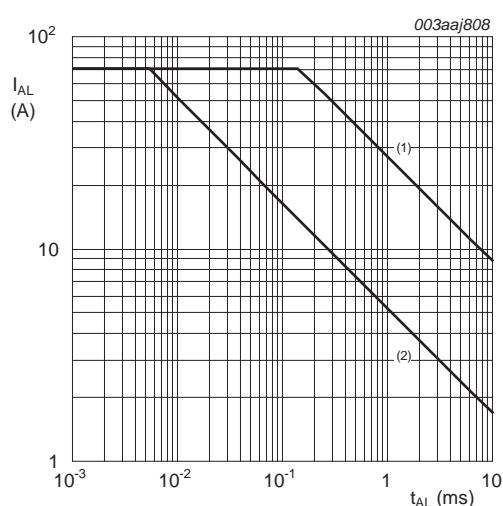


Fig 3. Single pulse avalanche rating; avalanche current as a function of avalanche time

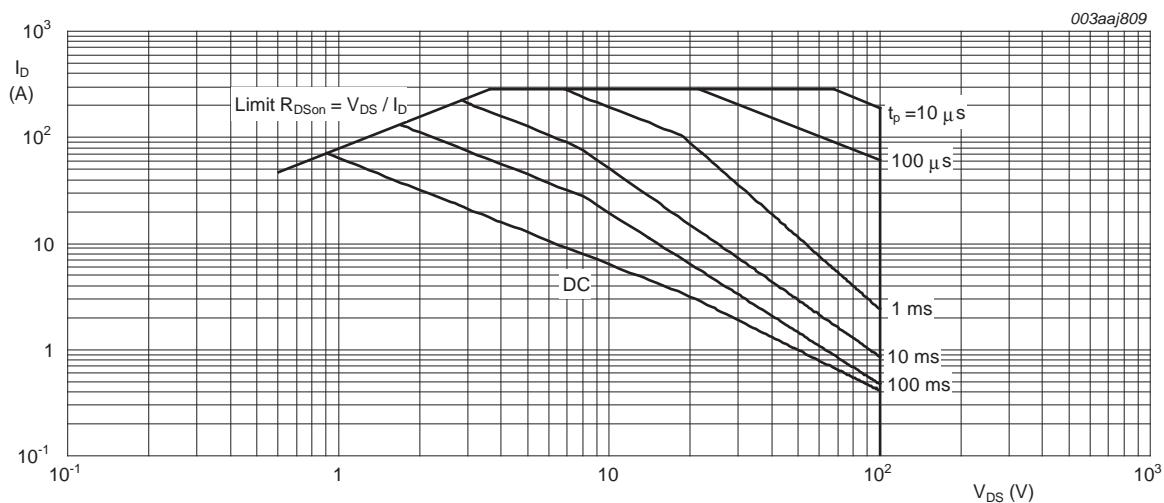


Fig 4. Safe operating area; continuous and peak drain currents as a function of drain-source voltage

5. Thermal characteristics

Table 5. Thermal characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
$R_{th(j\text{-}mb)}$	thermal resistance from junction to mounting base	see Figure 5	-	2.1	2.35	K/W
$R_{th(j\text{-}a)}$	thermal resistance from junction to ambient	vertical in free air	-	55	-	K/W

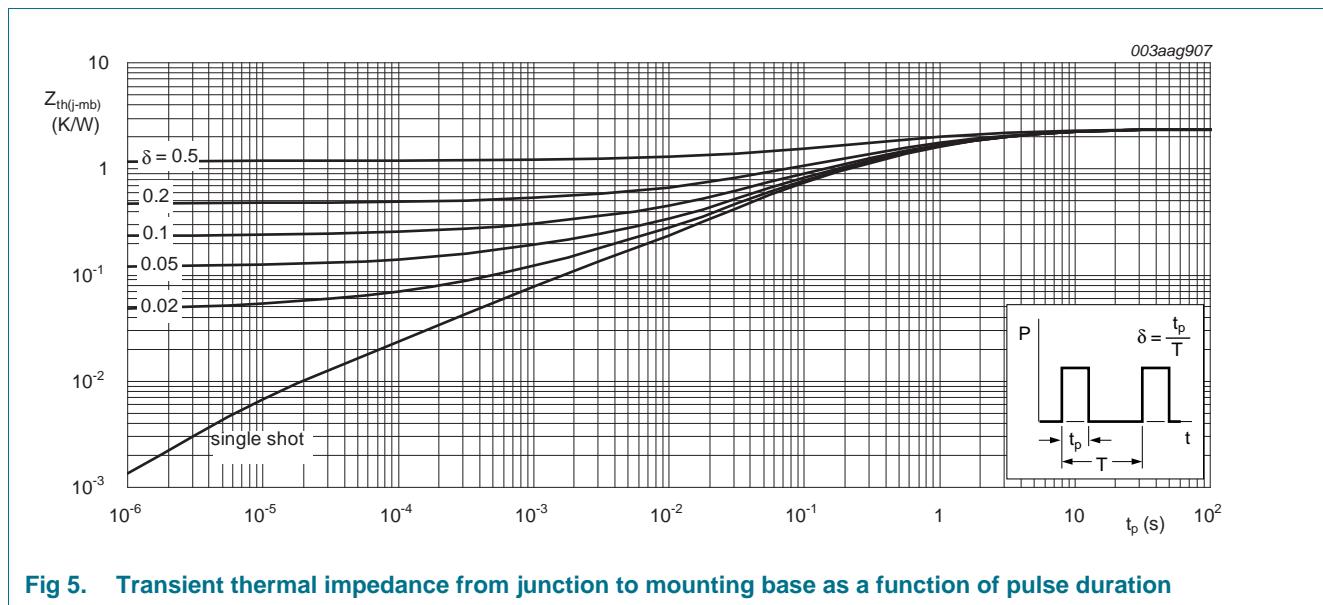


Fig 5. Transient thermal impedance from junction to mounting base as a function of pulse duration

6. Isolation characteristics

Table 6. Isolation characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
C_{isol}	isolation capacitance	[1]	-	10	-	pF
$V_{isol(RMS)}$	RMS isolation voltage	50 Hz $\leq f \leq$ 60 Hz; RH \leq 65 %; sinusoidal waveform; clean and dust free	-	-	2500	V

[1] $f = 1$ MHz

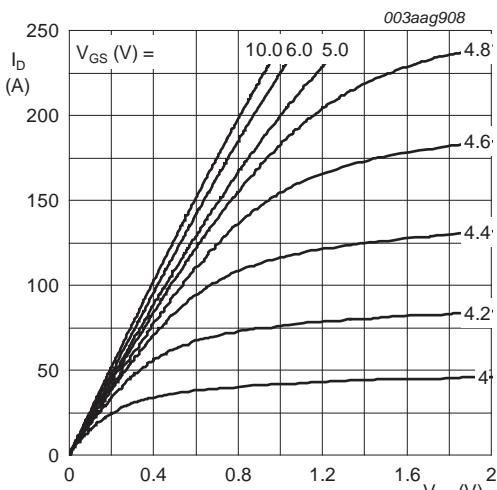
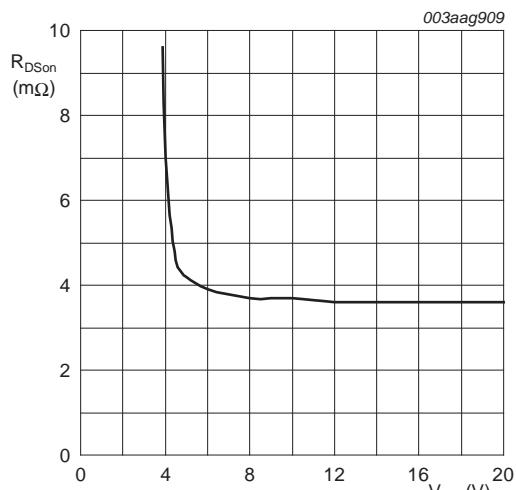
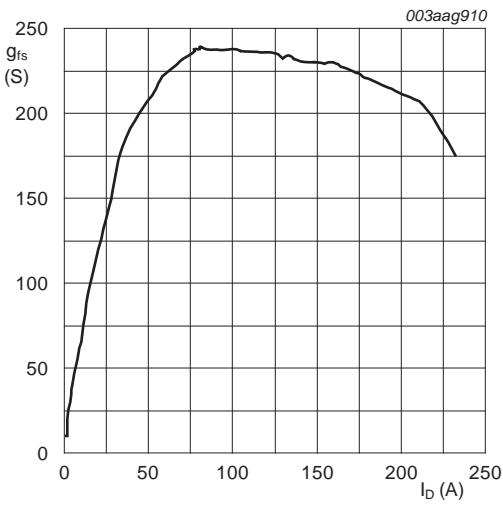
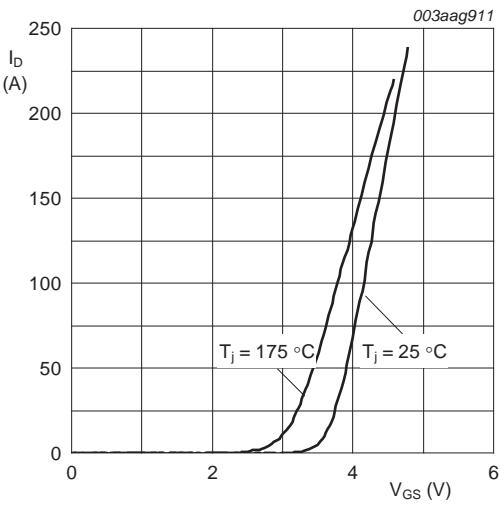
7. Characteristics

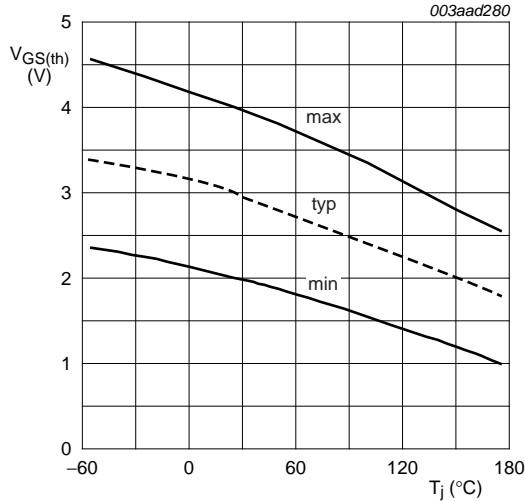
Table 7. Characteristics

Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Static characteristics						
$V_{(BR)DSS}$	drain-source breakdown voltage	$I_D = 250 \mu A; V_{GS} = 0 V; T_j = 25^\circ C$ $I_D = 250 \mu A; V_{GS} = 0 V; T_j = -55^\circ C$	100	-	-	V
$V_{GS(th)}$	gate-source threshold voltage	$I_D = 1 mA; V_{DS} = V_{GS}; T_j = 25^\circ C;$ see Figure 10 ; see Figure 11 $I_D = 1 mA; V_{DS} = V_{GS}; T_j = 175^\circ C;$ see Figure 10 $I_D = 1 mA; V_{DS} = V_{GS}; T_j = -55^\circ C;$ see Figure 10	2	3	4	V
I_{DSS}	drain leakage current	$V_{DS} = 100 V; V_{GS} = 0 V; T_j = 25^\circ C$ $V_{DS} = 100 V; V_{GS} = 0 V; T_j = 100^\circ C$	-	-	10	μA
I_{GSS}	gate leakage current	$V_{GS} = 20 V; V_{DS} = 0 V; T_j = 25^\circ C$ $V_{GS} = -20 V; V_{DS} = 0 V; T_j = 25^\circ C$	-	2	100	nA
R_{DSon}	drain-source on-state resistance	$V_{GS} = 10 V; I_D = 15 A; T_j = 25^\circ C;$ see Figure 12 ; see Figure 13 $V_{GS} = 10 V; I_D = 15 A; T_j = 100^\circ C;$ see Figure 13 $V_{GS} = 10 V; I_D = 15 A; T_j = 175^\circ C;$ see Figure 13	-	3.95	4.6	$m\Omega$
R_G	internal gate resistance (AC)	$f = 1 MHz$	-	0.9	-	Ω
Dynamic characteristics						
$Q_{G(tot)}$	total gate charge	$I_D = 15 A; V_{DS} = 50 V; V_{GS} = 10 V$; see Figure 14 ; see Figure 15	-	153	-	nC
Q_{GS}	gate-source charge		-	28	-	nC
$Q_{GS(th)}$	pre-threshold gate-source charge		-	25	-	nC
$Q_{GS(th-pl)}$	post-threshold gate-source charge		-	3	-	nC
Q_{GD}	gate-drain charge		-	40	-	nC
$V_{GS(pl)}$	gate-source plateau voltage	$I_D = 15 A; V_{DS} = 50 V$; see Figure 14 ; see Figure 15	-	3.5	-	V
C_{iss}	input capacitance	$V_{DS} = 50 V; V_{GS} = 0 V; f = 1 MHz;$ $T_j = 25^\circ C$; see Figure 16 ; see Figure 17	-	9900	-	pF
C_{oss}	output capacitance	$V_{DS} = 50 V; V_{GS} = 0 V; f = 1 MHz;$ $T_j = 25^\circ C$; see Figure 16	-	660	-	pF
C_{rss}	reverse transfer capacitance	$V_{DS} = 50 V; V_{GS} = 0 V; f = 1 MHz;$ $T_j = 25^\circ C$; see Figure 16 ; see Figure 17	-	381	-	pF
$t_{d(on)}$	turn-on delay time	$V_{DS} = 50 V; R_L = 4 \Omega; V_{GS} = 10 V;$	-	35	-	ns
t_r	rise time	$R_{G(ext)} = 4.7 \Omega; T_j = 25^\circ C$	-	40	-	ns
$t_{d(off)}$	turn-off delay time		-	170	-	ns
t_f	fall time		-	71	-	ns

Table 7. Characteristics ...continued

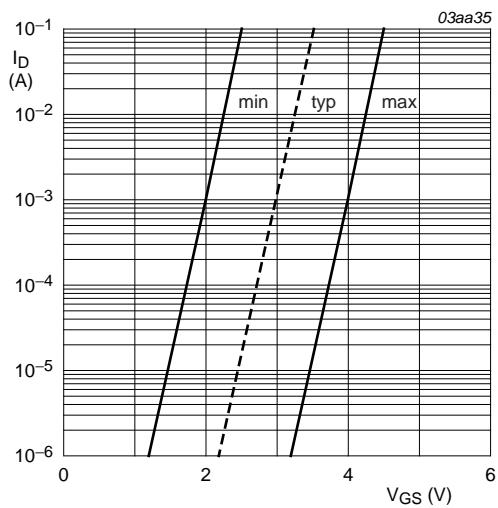
Symbol	Parameter	Conditions	Min	Typ	Max	Unit
Source-drain diode						
V_{SD}	source-drain voltage	$I_S = 10 \text{ A}; V_{GS} = 0 \text{ V}; T_j = 25^\circ\text{C}$; see Figure 18	-	0.72	1.2	V
t_{rr}	reverse recovery time	$I_S = 10 \text{ A}; dI_S/dt = -100 \text{ A}/\mu\text{s}$	-	63	-	ns
Q_r	recovered charge	$V_{GS} = 0 \text{ V}; V_{DS} = 50 \text{ V}$	-	173	-	nC

 $T_j = 25^\circ\text{C}$ **Fig 6. Output characteristics; drain current as a function of drain-source voltage; typical values** $T_j = 25^\circ\text{C}; I_D = 15\text{A}$ **Fig 7. Drain-source on-state resistance as a function of gate-source voltage; typical values** $T_j = 25^\circ\text{C}; V_{DS} = 20\text{V}$ **Fig 8. Forward transconductance as a function of drain current; typical values** $V_{DS} = 20\text{V}$ **Fig 9. Transfer characteristics; drain current as a function of gate-source voltage; typical values**



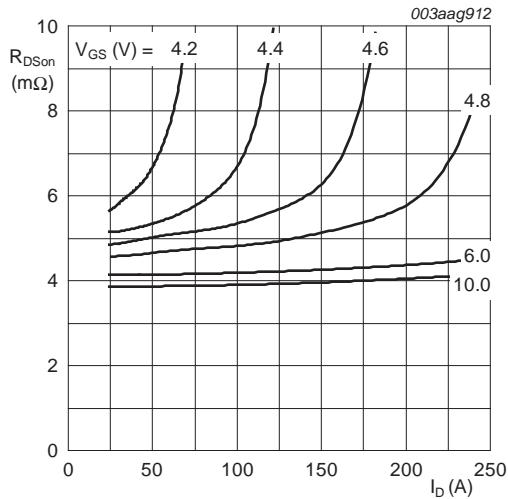
$I_D = 1 \text{ mA}; V_{DS} = V_{GS}$

Fig 10. Gate-source threshold voltage as a function of junction temperature



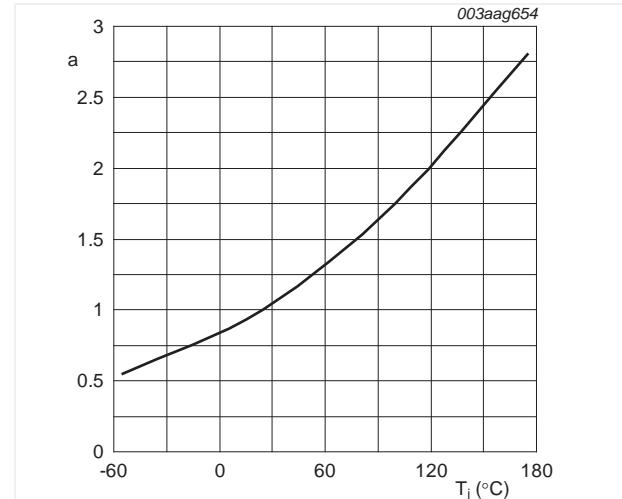
$T_j = 25^{\circ}\text{C}; V_{DS} = 5\text{V}$

Fig 11. Sub-threshold drain current as a function of gate-source voltage



$T_j = 25^{\circ}\text{C}$

Fig 12. Drain-source on-state resistance as a function of drain current; typical values



$$a = \frac{R_{DSon}}{R_{DSon}(25^{\circ}\text{C})}$$

Fig 13. Normalized drain-source on-state resistance factor as a function of junction temperature

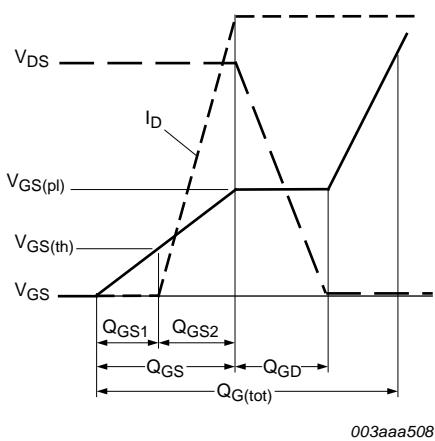


Fig 14. Gate charge waveform definitions

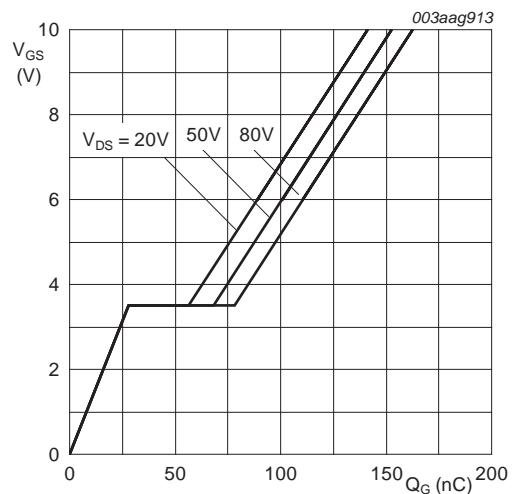
 $T_f = 25^\circ C; I_D = 15A$

Fig 15. Gate-source voltage as a function of gate charge; typical values

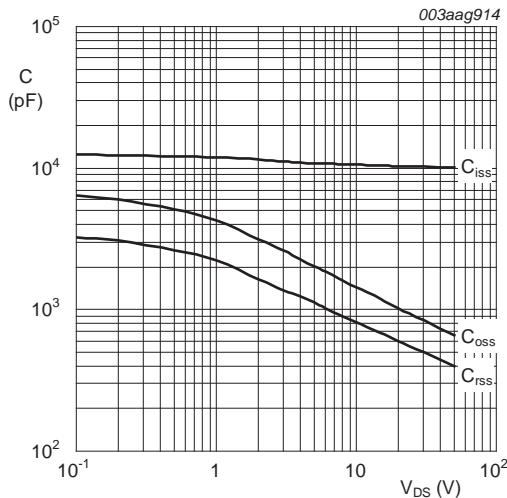


Fig 16. Input, output and reverse transfer capacitances as a function of drain-source voltage; typical values

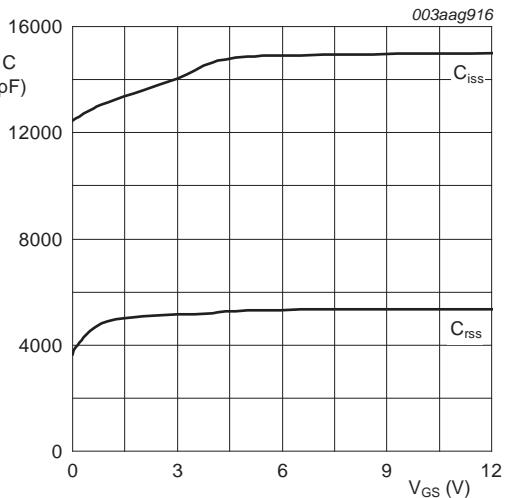


Fig 17. Input and reverse transfer capacitances as a function of gate-source voltage, typical values

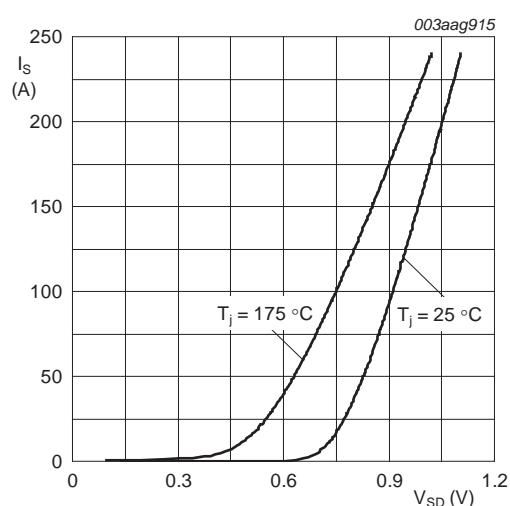


Fig 18. Source current as a function of source-drain voltage; typical values

8. Package outline

Plastic single-ended package; isolated heatsink mounted;
1 mounting hole; 3-lead TO-220 'full pack'

SOT186A

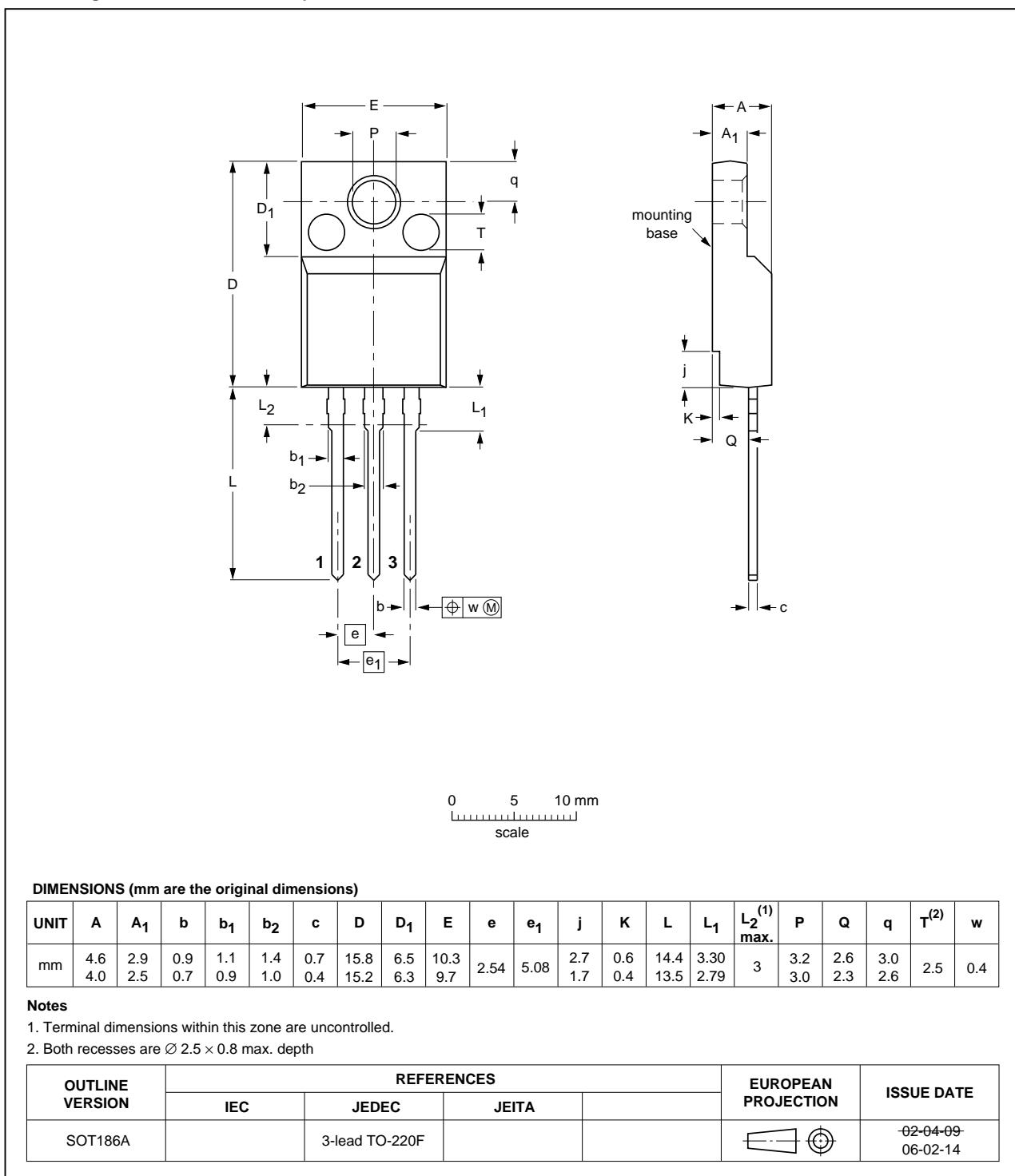


Fig 19. SOT186A

9. Revision history

Table 8. Revision history

Document ID	Release date	Data sheet status	Change notice	Supersedes
PSMN4R6-100XS v.1	20120703	Product data sheet	-	-

10. Legal information

10.1 Data sheet status

Document status ^[1] [2]	Product status ^[3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

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